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January 2011

FDQ7236AS

Dual Notebook Power Supply N-Channel PowerTrench® in SO-14 Package

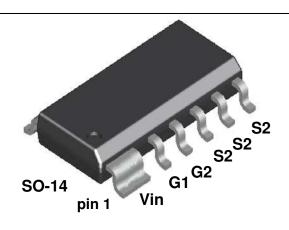
General Description

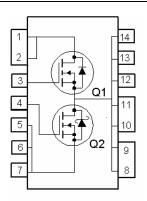
The FDQ7236AS is designed to replace two single SO-8 MOSFETs in DC to DC power supplies. The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the low-side switch (Q2) is optimized to reduce conduction losses using Fairchild's SyncFET TM technology. The FDQ7236AS includes a patented combination of a MOSFET monolithically integrated with a Schottky diode.

Features

- **Q2**: 14 A, 30V. $R_{DS(on)} = 8.7 \text{ m}\Omega$ @ $V_{GS} = 10V$ $R_{DS(on)} = 10.5 \text{ m}\Omega$ @ $V_{GS} = 4.5V$
- Q1: 11 A, 30V. $R_{DS(on)} = 13.2 \text{ m}\Omega$ @ $V_{GS} = 10V$ $R_{DS(on)} = 16 \text{ m}\Omega$ @ $V_{GS} = 4.5V$







Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter	Q2	Q1	Units
V _{DSS}	Drain-Source Voltage	30	30	V
V_{GSS}	Gate-Source Voltage	±20	±20	V
I _D	Drain Current - Continuous (Note 1a)	14	11	Α
	- Pulsed	50	50	
P _D	Power Dissipation for Single Operation (Note 1a & 1b)	2.4	1.8	W
	(Note 1c & 1d)	1.3	1.1	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	–55 to	°C	

Thermal Characteristics

R _{θJA}	Thermal Resistance, Junction-to-Ambient (Note 1a & 1b)	52	68	°C/W
	(Note 1c & 1d)	94	118	

Package Marking and Ordering Information

Device Marking Device Rec		Reel Size	Tape width	Quantity
FDQ7236AS	FDQ7236AS	13"	16mm	2500 units

Symbol	Parameter	Test C	Conditions	Type	Min	Тур	Max	Units
Off Cha	racteristics							
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V,$ $V_{GS} = 0 V,$	$I_D = 1 \text{ mA}$ $I_D = 250 \mu\text{A}$	Q2 Q1	30 30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = 10 \text{ mA}, \text{ Re}$	eferenced to 25°C eferenced to 25°C	Q2 Q1		25 24		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	,		Q2 Q1			500 1	μА
		$V_{DS} = 24 \text{ V}, \text{ V}_{OS}$ $T_{J} = 125^{\circ}\text{C}$		Q2 Q1		5.6 40		mA μA
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V},$	$V_{DS} = 0 V$	ALL			±100	nA
On Cha	racteristics (Note 2)							
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS},$ $V_{DS} = V_{GS},$	$I_D = 1 \text{ mA}$ $I_D = 250 \mu A$	Q2 Q1	1	1.8 1.7	3 3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_{,J}}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 10 \text{ mA}, \text{ Re}$	eferenced to 25°C eferenced to 25°C	Q2 Q1		-3 -4		mV/°C
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V},$ $V_{GS} = 4.5 \text{ V},$	I _D = 14 A I _D = 13 A	Q2		7.2 8.7 10	8.7 10.5 12.5	mΩ
		$V_{GS} = 4.5 \text{ V}$	= $14A$, $T_J = 125$ °C $I_D = 11 A$ $I_D = 10 A$ = 11 , $T_J = 125$ °C	Q1		11 13 15	13.2 16 19	
$I_{D(on)}$	On-State Drain Current	$V_{GS} = 10 \text{ V},$ $V_{GS} = 10 \text{ V},$	= 11, $T_J = 125$ °C $V_{DS} = 5$ V $V_{DS} = 5$ V $I_D = 14$ A	Q2 Q1	50 50			Α
g FS	Forward Transconductance	$V_{DS} = 10 \text{ V},$ $V_{DS} = 10 \text{ V},$	I _D = 14 A I _D = 11 A	Q2 Q1		58 43		S
Dvnami	c Characteristics							
C _{iss}	Input Capacitance	V _{DS} = 15 V,	V _{GS} = 0 V,	Q2 Q1		1530 920		pF
C _{oss}	Output Capacitance	f = 1.0 MHz	,	Q2 Q1		440 190		pF
C _{rss}	Reverse Transfer Capacitance			Q2 Q1		160 120		pF
R_g	Gate Resistance	$V_{GS} = 15 \text{mV}, f$	= 1.0 MHz	Q2 Q1		1.9 1.9		Ω

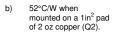
Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Switchi	ng Characteristics (Note 2)						
$t_{d(on)}$	Turn-On Delay Time		Q2 Q1		12 9	21 18	ns
t _r	Turn-On Rise Time	- - - -	Q2		13	23	ns
$t_{d(off)}$	Turn-Off Delay Time	$ \begin{vmatrix} V_{DD} = 15 \text{ V}, & I_D = 1 \text{ A}, \\ V_{GS} = 10 \text{ V}, & R_{GEN} = 6 \Omega \\ \end{vmatrix} $	Q1 Q2 Q1		5 30 27	10 49 43	ns
t _f	Turn-Off Fall Time		Q2 Q1		19 4	35 8	ns
$t_{\text{d(on)}}$	Turn-On Delay Time		Q2 Q1		17 11	30 20	ns
t _r	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, \qquad I_{D} = 1 \text{ A},$	Q2 Q1		18 15	32 26	ns
$t_{\text{d(off)}} \\$	Turn-Off Delay Time	$V_{GS} = 4.5V$, $R_{GEN} = 6 \Omega$	Q2 Q1		28 16	44 29	ns
tf	Turn-Off Fall Time		Q2 Q1		13 9	23 18	ns
$Q_{g(TOT)}$	Total Gate Charge, V _{GS} = 10V	Q2 V _{DS} = 15 V, I _D = 14A	Q2 Q1		28 17	39 24	nC
$Q_{g(TOT)}$	Total Gate Charge, V _{GS} = 5V	Q1	Q2 Q1		15 9	21 19	nC
Q_{gs}	Gate-Source Charge	$V_{DS} = 15 \text{ V}, I_{D} = 11 \text{ A}$	Q2 Q1		4.1 2.7		nC
Q_{gd}	Gate-Drain Charge		Q2 Q1		4.9 3.3		nC
Drain-S	ource Diode Characteristic	s and Maximum Ratings					
Is	Maximum Continuous Drain-Source		Q2 Q1			3.4 2.1	Α
V_{SD}	Drain-Source Diode Forward Voltage	$ \begin{array}{cccccccccccccccccccccccccccccccccccc$	Q2 Q1		0.5 0.4 0.7	0.7 1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 14A	Q2		22		ns
Q _{rr}	Diode Reverse Recovery Charge	$dI_F/dt = 300 A/\mu s$			15		nC
t _{rr}	Diode Reverse Recovery Time	I _F = 11A	Q1		16		ns
Q _{rr}	Diode Reverse Recovery Charge	$dI_F/dt = 100 A/\mu s$			5		nC

NOTE:

 R_{0,IA} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0,IC} is guaranteed by design while R_{0,CA} is determined by the user's board design.



a) 68°C/W when mounted on a 1in² pad of 2 oz copper (Q1).





- 118°C/W when mounted on a minimum pad of 2 oz copper (Q1).
- d) 94°C/W when mounted on a minimum pad of 2 oz copper (Q2).

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%

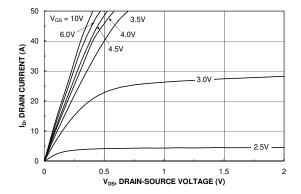


Figure 1. On-Region Characteristics.

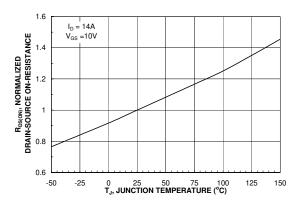


Figure 3. On-Resistance Variation with Temperature.

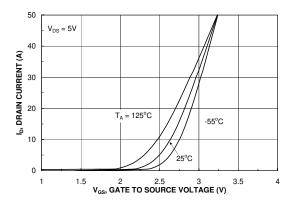


Figure 5. Transfer Characteristics.

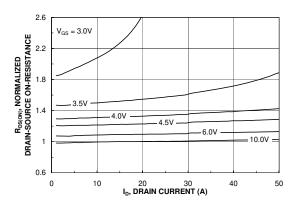


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

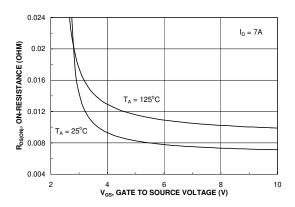


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

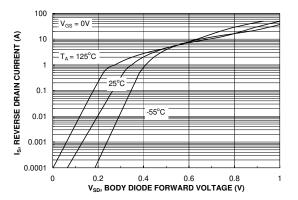
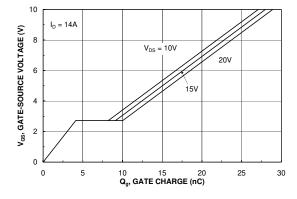


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.



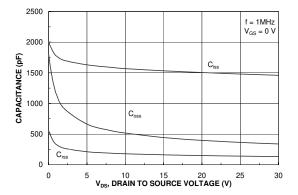
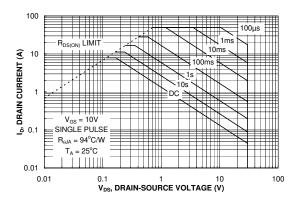


Figure 7. Gate Charge Characteristics.





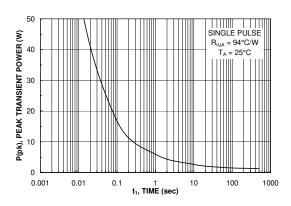


Figure 9. Maximum Safe Operating Area.



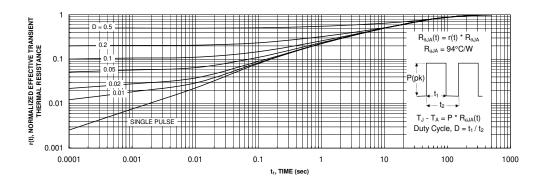
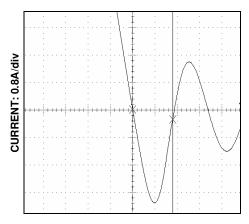


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1d. Transient thermal response will change depending on the circuit board design

SyncFET Schottky Body Diode Characteristics

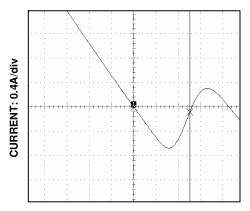
Fairchild's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 12 shows the reverse recovery characteristic of the FDQ7236AS Q2.



TIME: 12nS/div

Figure 12. FDQ7236AS SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 13 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET(FDS6670A).



TIME: 12nS/div

Figure 13. Non-SyncFET (FDS6670A) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power dissipated in the device.

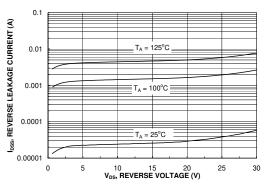


Figure 14. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

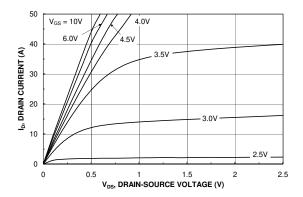


Figure 15. On-Region Characteristics.

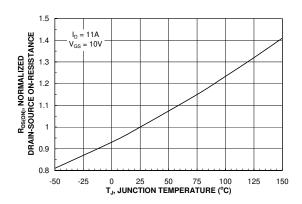


Figure 17. On-Resistance Variation with Temperature.

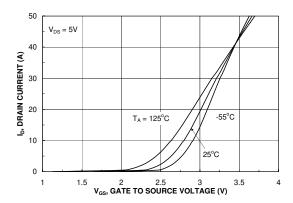


Figure 19. Transfer Characteristics.

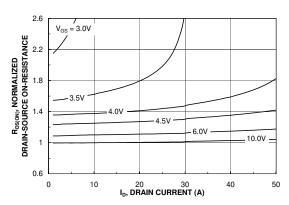


Figure 16. On-Resistance Variation with Drain Current and Gate Voltage.

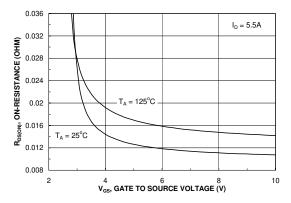


Figure 18. On-Resistance Variation with Gate-to-Source Voltage.

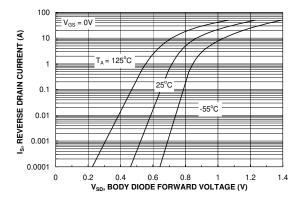
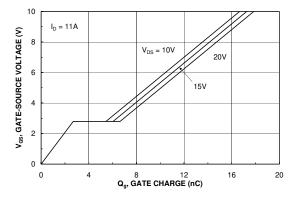


Figure 20. Body Diode Forward Voltage Variation with Source Current and Temperature.



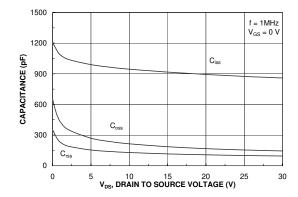
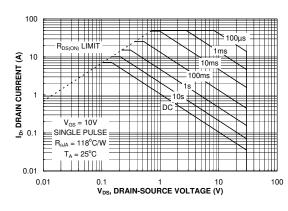


Figure 21. Gate Charge Characteristics.





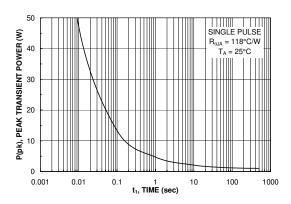


Figure 23. Maximum Safe Operating Area.

Figure 24. Single Pulse Maximum Power Dissipation.

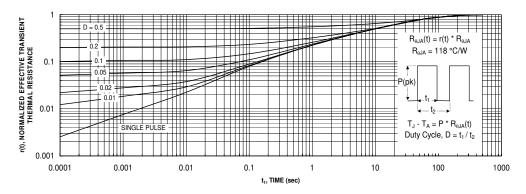


Figure 25. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c Transient thermal response will change depending on the circuit board design.





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